

## 1.0 SCOPE

This specification documents the detail requirements for space qualified die manufactured on Analog Devices, Inc.'s QML certified line per MIL-PRF-38534 class K except as modified herein.

The manufacturing flow described in the STANDARD DIE PRODUCTS PROGRAM brochure at <<http://www.analog.com/aerospace>> is to be considered a part of this specification.

This data sheet specifically details the space grade version of this product. A more detailed operational description and a complete datasheet for commercial product grades can be found at [www.analog.com/DAC08](http://www.analog.com/DAC08)

## 2.0 Part Number. The complete part number(s) of this specification follow:

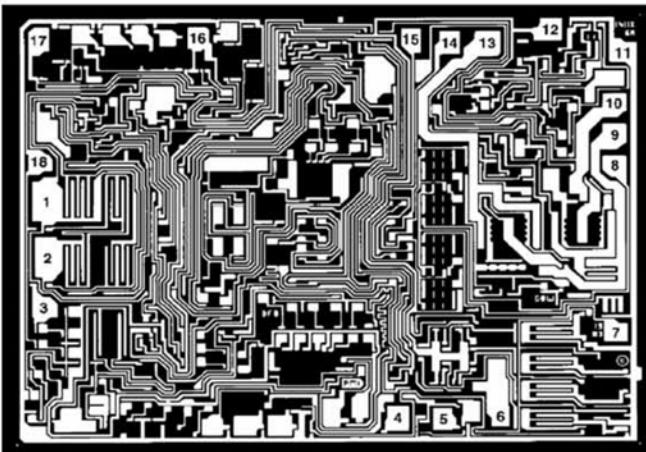
<u>Part Number</u>	<u>Description</u>
<b>AMP01-000C</b>	Low-Noise Precision Instrumentation Amplifier

## 3.0 Die Information

### 3.1 Die Dimensions

Die Size	Die Thickness	Bond Pad Metalization
111 mil x 149 mil	19 mil $\pm$ 2 mil	Al/Cu

### 3.2 Die Picture



- |                          |                           |
|--------------------------|---------------------------|
| 1. R <sub>G</sub>        | 10. V- (OUTPUT)           |
| 2. R <sub>G</sub>        | 11. V-                    |
| 3. -INPUT                | 12. V+                    |
| 4. V <sub>OOS</sub> NULL | 13. V+ (OUTPUT)           |
| 5. V <sub>OOS</sub> NULL | 14. R <sub>S</sub>        |
| 6. TEST PIN*             | 15. R <sub>S</sub>        |
| 7. SENSE                 | 16. V <sub>IOS</sub> NULL |
| 8. REFERENCE             | 17. V <sub>IOS</sub> NULL |
| 9. OUTPUT                | 18. +INPUT                |

Make no electrical connection to unlabeled pads.

### **3.3 Absolute Maximum Ratings 1/**

Supply Voltage (V+ to V-)	.....	36V dc
Logic Inputs	.....	V- to (V- plus 36V dc)
Logic Control Voltage (V <sub>LC</sub> )	.....	V- to V+
Analog Current Outputs (at V- = 15V)	.....	4.25mA
Reference Input (V <sub>REF+</sub> to V <sub>REF-</sub> )	.....	V- to V+
Reference Input Differential Voltage (V <sub>REF+</sub> to V <sub>REF-</sub> )	.....	±18V dc
Reference Input current (I <sub>VREF+</sub> )	.....	5mA
Storage Temperature Range	.....	-65°C to +125°C
Ambient Operating Temperature Range (T <sub>A</sub> )	.....	-55°C to +125°C

Absolute Maximum Ratings Notes:

1. Stresses above the absolute maximum rating may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.

### **4.0 Die Qualification**

In accordance with class-K version of MIL-PRF-38534, Appendix C, Table C-II, except as modified herein.

- (a) Qual Sample Size and Qual Acceptance Criteria – 25/2
- (b) Qual Sample Package – DIP
- (c) Pre-screen test post assembly required prior to die qualification, to remove all assembly related rejects.

**Table I - Dice Electrical Characteristics**

Parameter	Symbol	Conditions <u>1/</u>	Limit Min	Limit Max	Units
Power Supply	I <sub>+</sub>	V <sub>S</sub> = ±15V; I <sub>REF</sub> ≤ 2mA		3.8	mA
	I <sub>-</sub>		-7.8		
Full Range Current	I <sub>FR</sub>	V <sub>REF</sub> = 10V, R <sub>14</sub> , R <sub>15</sub> = 5kΩ	1.94	2.04	mA
Output Voltage Compliance	V <sub>OC</sub>	Full Range Current Change < 1/2 LSB	-10	18	V
Zero Scale Current	I <sub>ZS</sub>			2	µA
Full Range Symmetry	I <sub>FRS</sub>	I <sub>FR</sub> - $\bar{I}_{FR}$		±8	µA
Output Current Range	I <sub>OR1</sub>	V <sub>REF</sub> = 15V, V <sub>-</sub> = -10V, R <sub>14</sub> , R <sub>15</sub> = 5kΩ	2.1		mA
	I <sub>OR2</sub>	V <sub>REF</sub> = 25V, V <sub>-</sub> = -12V, R <sub>14</sub> , R <sub>15</sub> = 5kΩ	4.2		
Power Supply Sensitivity	PSSI <sub>FS+</sub>	V <sub>+</sub> = 4.5V to 18V, V <sub>-</sub> = -18V; I <sub>REF</sub> = 1mA		±0.01	%ΔI <sub>O</sub> %ΔV +
	PSSI <sub>FS-</sub>	V <sub>-</sub> = -4.5V to -18V, V <sub>+</sub> = +18V; I <sub>REF</sub> = 1mA		±0.01	%ΔI <sub>O</sub> %ΔV -
Reference Bias Current	I <sub>VREF-</sub>		0	-3	µA
Logic Input Levels	V <sub>IL</sub>	Logic “0”, V <sub>LC</sub> = 0V		0.8	V
	V <sub>IH</sub>	Logic “1”, V <sub>LC</sub> = 0V	2		
Logic Input Current (Each Bit)	I <sub>IL</sub>	V <sub>IN</sub> = -10V, V <sub>LC</sub> = 0V		-10	µA
	I <sub>IH</sub>	V <sub>IN</sub> = 18V, V <sub>LC</sub> = 0V		+10	
Logic Input Swing	V <sub>IS</sub>	I <sub>FR</sub> = 1.94mA (min) I <sub>FR</sub> = 2.04mA (max)	-10	+18	V
Resolution			8		Bits
Monotonicity			8		Bits
Nonlinearity	NL			±0.1	%FS

Table I Notes:

1. V<sub>S</sub> = ±15V, I<sub>REF</sub> = 2mA, and T<sub>A</sub> = +25°C, unless otherwise specified.

**Table II - Electrical Characteristics for Qualification**

Parameter	Symbol	Conditions <u>1/</u>	Sub-groups	Limit Min	Limit Max	Units
Power Supply <u>2/</u>	I+	V <sub>S</sub> = ±15V or +5V, -15V	1, 2, 3		3.8	mA
		V <sub>S</sub> = ±5V, I <sub>REF</sub> = 1mA				
		M, D, L, R			4.0	
	I-	V <sub>S</sub> = ±15V or +5V, -15V	1, 2, 3	-7.8		
		V <sub>S</sub> = ±5V; I <sub>REF</sub> = 1mA	1, 2, 3	-5.8		
		M, D, L, R <u>3/</u>	1	-8.0		
Full Range Current	I <sub>FR</sub>	V <sub>REF</sub> = 10V, R <sub>14</sub> , R <sub>15</sub> = 5kΩ	1, 2, 3	1.94	2.04	mA
		M, D, L, R <u>3/</u>	1	1.925	2.04	
Output Voltage Compliance <u>4/</u>	V <sub>OC</sub>	Full-Scale Current Change < 1/2 LSB	1, 2, 3	-10	+18	V
Zero Scale Current	I <sub>ZS</sub>		1, 2, 3		2	μA
		M, D, L, R <u>3/</u>	1		2	
Full Range Symmetry <u>4/</u>	I <sub>FRS</sub>	I <sub>FR</sub> - $\overline{I_{FR}}$	1, 2, 3		±8	μA
Output Current Range <u>4/</u>	I <sub>OR1</sub>	V <sub>REF</sub> = 15V, V <sub>-</sub> = -10V; R <sub>14</sub> , R <sub>15</sub> = 5kΩ	1, 2, 3	2.1		mA
	I <sub>OR2</sub>	V <sub>REF</sub> = 25V, V <sub>-</sub> = -12V; R <sub>14</sub> , R <sub>15</sub> = 5kΩ		4.2		
Power Supply Sensitivity <u>4/</u>	PSSI <sub>FS+</sub>	V <sub>+</sub> = 4.5V to 18V, V <sub>-</sub> = -18V, I <sub>REF</sub> = 1mA	1, 2, 3		±0.01	%ΔI <sub>O</sub> %ΔV <sub>+</sub>
	PSSI <sub>FS-</sub>	V <sub>-</sub> = -4.5V to -18V, V <sub>+</sub> = 18V, I <sub>REF</sub> = 1mA			±0.01	%ΔI <sub>O</sub> %ΔV <sub>-</sub>
Reference Bias Current <u>4/</u>	I <sub>VREF-</sub>		1, 2, 3	0	-3	μA
Logic Input Levels	V <sub>IL</sub>	Logic "0", V <sub>LC</sub> = 0V	1, 2, 3		0.8	V
		M, D, L, R <u>3/</u>	1		0.8	
	V <sub>IH</sub>	Logic "1", V <sub>LC</sub> = 0V	1, 2, 3	2.0		
		M, D, L, R <u>3/</u>	1	2.0		
Logic Input Current (Each Bit) <u>4/</u>	I <sub>IL</sub>	V <sub>IN</sub> = -10V, V <sub>LC</sub> = 0V	1, 2, 3		-10	μA
		M, D, L, R <u>3/</u>	1		-30	
	I <sub>IH</sub>	V <sub>IN</sub> = 18V, V <sub>LC</sub> = 0V	1, 2, 3		10	
		M, D, L, R <u>3/</u>	1		10	
Logic Input Swing <u>4/</u>	V <sub>IS</sub>	I <sub>FR</sub> = 1.94mA (min) I <sub>FR</sub> = 2.04mA (max)	1, 2, 3	-10	+18	V
Monotonicity <u>4/</u>			1, 2, 3	8		Bits
Nonlinearity	NL		1, 2, 3		±0.19	%FS
		M, D, L, R <u>3/</u>	1		±0.45	

<b>Table II - Electrical Characteristics for Qualification</b>						
Parameter	Symbol	Conditions <u>1/</u>	Sub- groups	Limit Min	Limit Max	Units
Full Scale Tempco <u>4/</u>	TCI <sub>FS</sub>		8		±80	ppm/°C

Table II Notes:

1.  $V_S = \pm 15V$ ,  $I_{REF} = 2mA$ , unless otherwise specified.
2. When the device is used in an un-biased state at high temperature only, and subsequently biased, the device supply currents may rise 30% above specification for as long as 30 seconds.
3. Devices tested at 100K.
4. This parameter not tested post irradiation.

<b>Table III - Life Test Endpoint and Delta Parameter</b> (Product is tested in accordance with Table II with the following exceptions)								
Parameter	Symbol	Sub-groups	Post Burn In Limit		Post Life Test Limit		Life Test Delta	Units
			Min	Max	Min	Max		
Full Range Current	$I_{FR}$	1	1.93	2.05	1.92	2.06	0.01	mA
	$\bar{I}_{FR}$							
Zero Scale Current	$I_{ZS}$	1		2.5		3	0.5	$\mu A$
	$\bar{I}_{ZS}$							

## 5.0 Life Test/Burn-In Information

- 5.1 HTRB is not applicable for this drawing.
- 5.2 Burn-in is per MIL-STD-883 Method 1015 test condition B or C.
- 5.3 Steady state life test is per MIL-STD-883 Method 1005.

**DAC08** 8-Bit High-Speed  
Multiplying D/A Converter

Rev	Description of Change	Date
A	Initiate	20-DEC-01
B	Update web address	Aug. 5, 2003
C	Add radiation limits same as SMD	Aug. 25, 2003